











FCC RF Test Report

Product Name: Smart Phone

Model Number: DRA-L01

Report No.: SYBH(Z-RF)20180212006002-2001

FCC ID: QISDRA-L01

Reliability Laboratory of Huawei Technologies Co., Ltd.

(Global Compliance and Testing Center of Huawei Technologies Co., Ltd)

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Notice

- 1. The laboratory has passed the accreditation by China National Accreditation Service for Conformity Assessment (CNAS). The accreditation number is L0310.
- 2. The laboratory has passed the accreditation by The American Association for Laboratory Accreditation (A2LA). The accreditation number is 2174.01
- 3. The laboratory has been recognized by the US Federal Communications Commission (FCC) to perform compliance testing subject to the Commission's Certification rules. The Designation Number is CN1173, and the Test Firm Registration Number is 294140.
- 4. The laboratory has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 6369A-1.
- 5. The laboratory (Reliability Lab of Huawei Technologies Co., Ltd) is also named "Global Compliance and Testing Center of Huawei Technologies Co., Ltd", the both names have coexisted since 2009.
- 6. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- 7. The test report is invalid if there is any evidence of erasure and/or falsification.
- 8. The test report is only valid for the test samples.
- 9. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

Applicant: Huawei Technologies Co., Ltd.

Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,

Bantian, Longgang District, Shenzhen, 518129, P.R.C

Date of Receipt Sample:2018-03-30Start Date of Test:2018-03-30End Date of Test:2018-04-15

Test Result: Pass

Approved by Senior 2018-04-15 Roger zhang Roger zhang

Engineer: Date Name Signature

Prepared by:

2018-04-15 Pan Man

Date Name Signature



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1 General Information

1.1 Applied Standard

Applied Rules: 47 CFR FCC Part 02

47 CFR FCC Part 22 47 CFR FCC Part 24 47 CFR FCC Part 27

Test Method: FCC KDB 971168 D01 Power Meas License Digital Systems v03

1.2 Test Location

Test Location: Reliability Laboratory of Huawei Technologies Co., Ltd.

Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,

Bantian, Longgang District, Shenzhen, 518129, P.R.C

1.3 Test Environment Condition

Ambient Temperature: 19.5 to 25 °C

Ambient Relative Humidity: 40 to 55 %

Atmospheric Pressure: Not applicable



2 Test Summary

2.1 Cellular Band (824-849 MHz paired with 869-894 MHz)

Test Item	FCC Rule No.	Requirements	Test Result	Verdict (Note1)	
Effective (Isotropic) Radiated Power Output Data §2.1046, §22.913		FCC: ERP ≤ 7 W.	Appendix A	Pass	
Peak-Average Ratio		Limit≤13 dB	Appendix B	Pass	
Modulation Characteristics	§2.1047	Digital modulation	Appendix C	Pass	
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Appendix D	Pass	
Band Edges Compliance	§2.1051, §22.917	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Appendix E	Pass	
Spurious Emission at Antenna Terminals	§2.1051, §22.917	FCC: ≤ -13 dBm/100 kHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Appendix F	Pass	
Field Strength of Spurious Radiation	§2.1053, §22.917	FCC: ≤ -13 dBm/100 kHz.	Appendix G	Pass	
Frequency Stability	§2.1055, §22.355	≤ ±2.5ppm.	Appendix H	Pass	
NOTE: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".					



2.2 PCS Band (1850-1910 MHz paired with 1930-1990 MHz)

Test Item	FCC Rule No.	Requirements	Test Result	Verdict (Note1)
Effective (Isotropic) Radiated Power Output Data §2.1046, §24.232		EIRP ≤ 2 W	Appendix A	Pass
Peak-Average Ratio	§2.1046, §24.232	Limit≤13 dB	Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Appendix C	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Appendix D	Pass
Band Edges Compliance	§2.1051, §24.238	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Appendix E	Pass
Spurious Emission at Antenna Terminals	§2.1051, §24.238	≤ -13 dBm/1 MHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Appendix F	Pass
Field Strength of Spurious Radiation			Appendix G	Pass
Frequency Stability	§2.1055, §24.235	≤ ±2.5 ppm.	Appendix H	Pass
NOTE: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".				



2.3 BRS&EBS Band (2500-2570 MHz paired with 2620-2690 MHz)

Test Item	FCC Rule	Requirements	Test Result	Verdict (Note1)
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(h)	EIRP ≤ 2W	Appendix A	Pass
Peak-Average Ratio	§27.50(a)	Limit≤13 dB	Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Appendix C	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Appendix D	Pass
Band Edges Compliance	§2.1051, §27.53(m4)	FCC: 2%*EBW Channel 2%*EBW -10dBm Edge -10dBm -10dBm 1/m -13dBm	Appendix E	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)	Channel Edge -25dBm/ 1 MHz 1	Appendix F	Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(m)	Channel Edge -25dBm/ 1 MHz 1 MHz 1 MHz 1 MHz 25 dBm/ 1 MHz 1 MHz 1 MHz 1 MHz 1 MHz 1 MHz 4 MHz 1 MHz 4 MHz 5 MHz 8 K=Max {6MHz, EBW}	Appendix G	Pass
Frequency Stability	§2.1055, §27.54	Within authorized bands of operation/frequency block.	Appendix H	Pass
NOTE:	For the verdict	, the "N/A" denotes "not applicable", the "N/T"	denotes "not tested	l".



3 Description of the Equipment under Test (EUT)

3.1 General Description

DRA-L01 is subscriber equipment in the GSM/WCDMA/LTE system. The GSM frequency band includes GSM850 and GSM900 and DCS1800 and PCS1900. The UMTS frequency band is B1 and B5 and B8. The LTE frequency band is B1 and B3 and B5 and B7 and B8 and B20. The Mobile Phone implements such functions as RF signal receiving/transmitting, LTE/HSPA/UMTS and GSM/GPRS/EDGE protocol processing, voice, video MMS service, GPS, AGPS and WIFI etc. Externally it provides one micro SD card interface, one earphone port (to provide voice service) and one SIM card interface. DRA-L01 is single SIM smart phone. It also provides Bluetooth module to synchronize data between a PC and the phone, or to use the built-in modem of the phone to access the Internet with a PC, or to exchange data with other Bluetooth devices.

Note: Only GSM850/1900&WCDMA850<E B5/B7 test data included in this report.

3.2 EUT Identity

NOTE: Unless otherwise noted in the report, the functional boards installed in the units shall be selected from the below list, but not means all the functional boards listed below shall be installed in one unit.

3.2.1 Board

Board			
Description	Hardware Version	Software Version	
Main Board	HL1DURAM	DRA-L01 1.0.0.38(C900)	

3.2.2 Sub-Assembly

Sub-Assembly					
Sub-Assembly	Model	Manufacturer	Description		
Name	iviodei	Manufacturer			
Adapter	HW-050100U01	Huawei Technologies	Input Voltage: ~100-240V 50/60Hz 0.2A		
Adapter		Co., Ltd.	Output Voltage: 5V === 1A		
	HB405979ECW	Huawei Technologies	Rated capacity: 2920mAh		
Battery		Co., Ltd.	Nominal Voltage:3.82 V		
		00., Ltd.	Charging Voltage: +4.4V		



3.3 Technical Specification

Characteristics	Description		
Radio System Type	☑ GSM☑ UMTS☑ LTE		
Supported Frequency Range	GSM850/ WCDMA850	Transmission (TX): 824 to 849 MHz Receiving (RX): 869 to 894 MHz	
	GSM1900	Transmission (TX): 1850 to 1910 MHz Receiving (RX): 1930 to 1990 MHz	
	LTE BAND5	Transmission (TX): 824 to 849 MHz Receiving (RX): 869 to 894 MHz	
	LTE BAND7	Transmission (TX): 2500 to 2570 MHz Receiving (RX): 2620 to 2690 MHz	
TX and RX Antenna Ports	TX & RX port:	1	
	TX-only port:	0	
	RX-only port:	1	
Target TX Output Power	GSM850: 33dBm GSM1900 30dBm UMTS850 24dBm LTE Band 5: 24dBm LTE Band 7: 23dBm		
Supported Channel Bandwidth	GSM system:		
	UMTS system:	⊠ 5 MHz	
	LTE band 5	⊠1.4MHz, ⊠3MHz ,⊠5MHz ,⊠10MHz	
	LTE band 7	⊠5MHz, ⊠10MHz ,⊠15MHz ,⊠20MHz	
Designation of Emissions	GSM850:	246KGXW, 244KG7W	
(Note: the necessary bandwidth of	GSM1900:	246KGXW, 250KG7W	
which is the worst value from the	UMTS850:	4M18F9W	
measured occupied bandwidths for	LTE BAND5:	1M09G7D (1.4 MHz QPSK modulation),	
each type of channel bandwidth		1M10W7D (1.4 MHz 16QAM modulation)	
configuration.)		2M69G7D (3 MHz QPSK modulation),	
		2M69W7D (3 MHz 16QAM modulation)	
		4M53G7D (5 MHz QPSK modulation),	
		4M52W7D (5 MHz 16QAM modulation)	
		9M02G7D (10 MHz QPSK modulation),	
		9M03W7D (10 MHz 16QAM modulation)	
	LTE BAND7:	4M54G7D (5 MHz QPSK modulation),	
		4M52W7D (5 MHz 16QAM modulation)	
		9M03G7D (10 MHz QPSK modulation),	
		9M03W7D (10 MHz 16QAM modulation)	
		13M5G7D (15 MHz QPSK modulation),	



Characteristics	Description		
	13M5W7D (15 MHz 16QAM modulation)		
	18M0G7D (20 MHz QPSK modulation),	ļ	
	18M0W7D (20 MHz 16QAM modulation)		



4 General Test Conditions / Configurations

4.1 Test Modes

NOTE: The test mode(s) are selected according to relevant radio technology specifications.

Test Mode	Test Modes Description
GSM/TM1	GSM system, GSM/GPRS, GMSK modulation
GSM/TM2	GSM system, EDGE, 8PSK modulation
UMTS/TM1	WCDMA system, QPSK modulation
LTE/TM1	LTE system, QPSK modulation
LTE/TM2	LTE system, 16QAM modulation

4.2 Test Environment

Environment Parameter	Selected Values During Tests	
Relative Humidity	Ambient	
Temperature	TN	Ambient
	VL	3.6V
Voltage	VN	3.82V
	VH	4.4V

NOTE: VL= lower extreme test voltage

VN= nominal voltage

VH= upper extreme test voltage

TN= normal temperature



4.3 Test Frequency

Test Mode	TX/RX	RF Channel		
r est Mode		Low (L)	Middle (M)	High (H)
		Channel 128	Channel 190	Channel 251
GSM850	TX	824.2MHz	836.6MHz	848.8MHz
GSIVI650	RX	Channel 128	Channel 190	Channel 251
	KA	869.2MHz	881.6MHz	893.8MHz
	тх	Channel 4132	Channel 4182	Channel 4233
WCDMA850		826.4MHz	836.4MHz	846.6MHz
VVCDIVIA650	RX	Channel 4357	Channel 4407	Channel 4458
		871.4MHz	881.4MHz	891.6MHz
Test Mode	TX / RX		RF Channel	
rest wode		Low (L)	Middle (M)	High (H)
	TX	Channel 512	Channel 661	Channel 810
GSM1900	1.7	1850.2MHz	1880.0MHz	1909.8MHz
G2M1800	RX	Channel 512	Channel 661	Channel 810
		1930.2 MHz	1960.0 MHz	1989.8 MHz

Test Mode	TX / RX	RF Channel		
rest wode		Low (B)	Middle (M)	High (T)
	TX(1.4M)	Channel 20407	Channel 20525	Channel 20643
		824.7 MHz	836.5 MHz	848.3 MHz
LTE Band 5	TX(3M)	Channel 20415	Channel 20525	Channel 20635
		825.5 MHz	836.5 MHz	847.5 MHz
	TX(5M)	Channel 20425	Channel 20525	Channel 20625



Toot Mode	TX/RX	RF Channel			
Test Mode		Low (B)	Middle (M)	High (T)	
		826.5 MHz	836.5 MHz	846.5 MHz	
	TX(10M)	Channel 20450	Channel 20525	Channel 20600	
	TX(TOW)	829 MHz	836.5 MHz	844 MHz	
	RX(1.4M)	Channel 2407	Channel 2525	Channel 2643	
		869.7 MHz	881.5 MHz	893.3 MHz	
	RX (3M)	Channel 2415	Channel 2525	Channel 2635	
		870.5 MHz	881.5 MHz	892.5 MHz	
	RX(5M)	Channel 2425	Channel 2525	Channel 2625	
	KX(SIVI)	871.5 MHz	881.5 MHz	891.5 MHz	
	DV (40M)	Channel 2450	Channel 2525	Channel 2600	
	RX (10M)	874 MHz	881.5 MHz	889 MHz	

Test Mode	TX / RX	RF Channel			
rest Mode		Low (B)	Middle (M)	High (T)	
	TX (5M)	Channel 20775	Channel 21100	Channel 21425	
	17 (3141)	2502.5 MHz	2535 MHz	2567.5 MHz	
	TV (40N4)	Channel 20800	nel 20800 Channel 21100 Channel 2		
	TX (10M)	2505 MHz	2535 MHz	2565 MHz	
LTE Band 7	TX (15M)	Channel 20825	Channel 21100	Channel 21375	
		2507.5 MHz	2535 MHz	2562.5 MHz	
		Channel 20850	annel 20850 Channel 21100 Channel		
		2510 MHz	2535 MHz	2560 MHz	
	RX (5M)	Channel 2775	Channel 3100	Channel 3425	



Test Mode	TX/RX	RF Channel			
rest wode		Low (B)	Middle (M)	High (T)	
		2622.5 MHz	2655 MHz	2687.5 MHz	
	RX (10M)	Channel 2800	Channel 3100	Channel 3400	
		2625 MHz	2655 MHz	2685 MHz	
	RX (15M)	Channel 2825	Channel 3100	Channel 3375	
		2627.5 MHz	2655 MHz	2682.5 MHz	
		Channel 2850	Channel 3100	Channel 3350	
	RX (20M)	2630 MHz	2655 MHz	2680 MHz	



4.4 DESCRIPTION OF TESTS

4.4.1 Radiated Power and Radiated Spurious Emissions

Radiated spurious emissions are investigated indoors in a semi-anechoic chamber to determine the frequencies producing the worst case emissions. Final measurements for radiated power and radiated spurious emissions are performed on the 3 meter OATS per the guidelines of ANSI/TIA-603-D-2010. The equipment under test was transmitting while connected to its integral antenna and is placed on a wooden turntable 80cm above the ground plane and 3 meters from the receive antenna. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Emissions are also investigated with the receive antenna horizontally and vertically polarized.

A portable or small unlicensed wireless device shall be placed on a non-metallic test fixture or other non-metallic support during testing. The supporting fixture shall permit orientation of the EUT in each of three orthogonal (x, y, z) axis positions such that emissions from the EUT are maximized. Measure the EUT maximum RF power and record the result.

A half-wave dipole is then substituted in place of the EUT. For emissions above 3GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT.

The power of the emission is calculated using the following formula:

Pd [dBm] = Pg [dBm] - cable loss [dB] + antenna gain [dBd/dBi]

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB].

The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of 43 + 10log₁₀(Power [Watts]).

Test Procedures Used

KDB 971168 D01 v03-Section 5.2.2 / KDB 971168 D01 v03-Section 5.8

ANSI/TIA-603-D-2010-Section 2.2.17 / ANSI/TIA-603-D-2010-Section 2.2.12

Note: Reference test setup 3



4.4.2 Peak-Average Ratio

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Test Procedures Used

KDB 971168 D01 v03-Section 5.7.2

Test Settings

- 1. The signal analyzer's CCDF measurement profile enabled
- 2. Frequency= carrier center frequency
- 3. Measurement BW > EBW of signal
- 4, for continuous transmissions, set to 1ms
- 5. Record the maximum PAPR level associated with a probability of 0.1%.

Note: Reference test setup 1



4.4.3 Occupied Bandwidth

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Test Procedures Used

KDB 971168 D01 v03-Section 4.3

Test Settings

- 1、SET RBW=1-5% of OBW
- 2、SET VBW ≥ 3*RBW
- 3. Detector: Peak
- 4. Trace mode= max hold.
- 5. Sweep= auto couple
- 6. Steps 1-5 were repeated after it is stable

Note: Reference test setup 1.



4.4.4 Band Edge Compliance

the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission power must be attenuated below the transmitting power (P) by a factor of at least 43+10log₁₀P dB.

Test Procedures Used

KDB 971168 D01 v03-Section 6

Test Settings

- 1、SET RBW ≥ 1% of Emission BW.
- 2, SET VBW about three times of RBW
- 3. Detector: RMS
- 4. Trace mode= max hold.
- 5、Span= 2MHz

Note: Reference test setup 1.



4.4.5 Spurious and Harmonic Emissions at Antenna Terminal

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Test Procedures Used

KDB 971168 D01 v03-Section 6

Test Settings

1. $9kHz\sim150kHz$, RBW = 1KHz, VBW $\geq 3\times RBW$,

150kHz~30MHz, RBW = 10KHz, VBW $\geq 3 \times$ RBW,

 $30MHz\sim1GHz$, RBW = 100 kHz, VBW = 300 kHz.

Above 1GHz, RBW = 1 MHz, VBW = 3 MHz.

- 2. Detector: Peak
- 3. Trace mode= max hold.

Note: Reference test setup 1.



4.4.6 Frequency Stability / Temperature Variation

Frequency stability testing is performed in accordance with the guidelines of ANSI/TIA-603-D-2010. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within ±0.00025% (±2.5 ppm) of the center frequency.

Time Period and Procedure:

- 1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
- 2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
- 3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Test Procedures Used

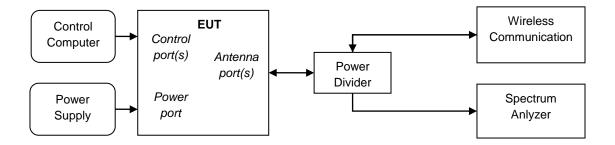
ANSI/TIA-603-D-2010

Note: Reference test setup 2.



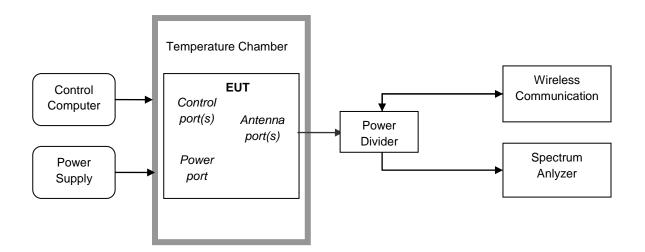
4.5 Test Setups

4.5.1 Test Setup 1





4.5.2 Test Setup 2

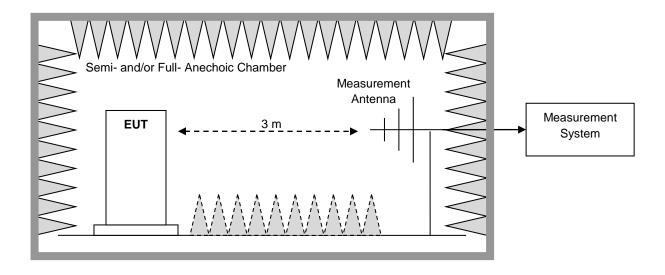




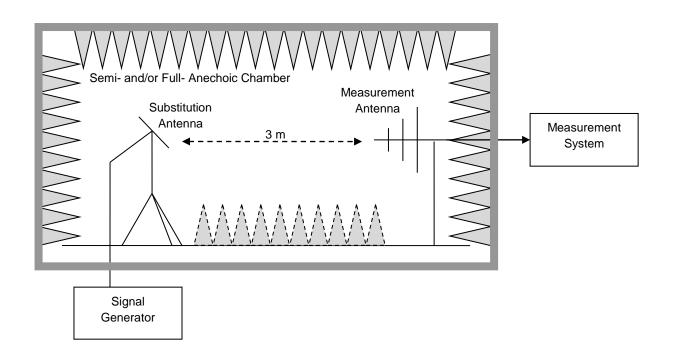
4.5.3 Test Setup 3

NOTE: Effective radiated power (ERP) and Equivalent Isotropic Radiated Power(EIRP) refers to the radiation power output of the EUT, assuming all emissions are radiated from half-wave dipole antennas.

4.5.3.1 Step 1: Pre-test



4.5.3.2 Step 2: Substitution method to verify the maximum ERP/EIRP





4.6 Test Conditions

Test Case		Test Conditions		
Transmit	Average Power,	Test Env.	Ambient Climate & Rated Voltage	
Output	Total	Test Setup	Test Setup 1	
Power Data		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
	Average Power,	Test Env.	Ambient Climate & Rated Voltage	
	Spectral Density	Test Setup	Test Setup 1	
	(if required)	RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
Peak-to-Avera	age Ratio	Test Env.	Ambient Climate & Rated Voltage	
(if required)		Test Setup	Test Setup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
Modulation Cl	haracteristics	Test Env.	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels	M	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
Bandwidth	Occupied	Test Env.	Ambient Climate & Rated Voltage	
	Bandwidth	Test Setup	Test Setup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
	Emission	Test Env.	Ambient Climate & Rated Voltage	
	Bandwidth	Test Setup	Test Setup 1	
	(if required)	RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
Band Edges (Compliance	Test Env.	Ambient Climate & Rated Voltage	
		Test Setup	Test Setup 1	
		RF Channels	L, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2	
Spurious Emis	ssion at Antenna	Test Env.	Ambient Climate & Rated Voltage	
Terminals		Test Setup	Test Setup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	



Test Case	Test Condition	st Conditions		
	Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2		
Field Strength of Spurious	Test Env.	Ambient Climate & Rated Voltage		
Radiation	Test Setup	Test Setup 3		
	Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1/TM2/TM3,LTE/TM1,LTE/TM2		
		NOTE: If applicable, the EUT conf. that has maximum power		
		density (based on the equivalent power level) is		
		selected.		
	RF Channels L, M, H			
	(TX)	(L= low channel, M= middle channel, H= high channel)		
Frequency Stability	Test Env.	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage;		
		(2) VL, VN and VH of Rated Voltage at Ambient Climate.		
	Test Setup	Test Setup 2		
RF Channels L, M, H		L, M, H		
	(TX)	(L= low channel, M= middle channel, H= high channel)		
	Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2		



5 <u>Main Test Instruments</u>

Main Test Equipments					
Equipment Name	Manufactur er	Model	Serial Number	Cal Date	Cal- Due
Power supply	KEITHLEY	2303	000500E	2017/5/31	2018/5/30
Wireless Communication Test set	Agilent	N4010A	MY49081592	2017/7/31	2018/7/30
Universal Radio Communication Tester	R&S	CMU200	110932	2017/5/2	2018/5/1
Spectrum Analyzer	Agilent	N9020A	MY52090652	2017/7/10	2018/7/9
Universal Radio Communication Tester	R&S	CMW500	126854	2017/10/19	2018/10/18
Signal Analyzer	R&S	FSQ31	200021	2017/7/31	2018/7/30
Spectrum Analyzer	Agilent	N9030A	MY49431698	2017/7/31	2018/7/30
Temperature Chamber	WEISS	WKL64	56246002940010	2017/12/13	2018/12/12
Signal generator	Agilent	E8257D	MY49281095	2017/7/31	2018/7/30
Vector Signal Generator	R&S	SMU200A	104162	2017/7/31	2018/7/30
Test receiver	R&S	ESU26	100387	2018/1/20	2019/1/19
Test receiver	R&S	ESCI	101163	2018/1/20	2019/1/19
Spectrum analyzer	R&S	FSU3	200474	2018/1/20	2019/1/19
Spectrum analyzer	R&S	FSU43	100144	2018/1/20	2019/1/19
LOOP Antennas(9kHz-30MHz)	R&S	HFH2-Z2	100262	2017/4/25	2019/4/25
LOOP Antennas(9kHz-30MHz)	R&S	HFH2-Z2	100263	2017/4/25	2019/4/25
Trilog Broadband Antenna (30M~3GHz)	SCHWARZ BECK	VULB 9163	9163-490	2017/3/29	2019/3/29
Trilog Broadband Antenna (30M~3GHz)	SCHWARZ BECK	VULB 9163	9163-521	2017/4/9	2019/4/9
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100304	2017/5/27	2019/5/27
Pyramidal Horn Antenna(18GHz-26.5GHz)	ETS-Lindgr en	3160-09	5140299	2017/7/20	2019/7/19
Artificial Main Network	R&S	ENV4200	100134	2017/5/15	2018/5/14
Line Impedance Stabilization Network	R&S	ENV216	100382	2017/5/15	2018/5/14
Power Detecting & Sampling Unit	R&S	OSP-B157	100914	2017/7/31	2018/7/30
Power supply	KEITHLEY	2303	000500E	2017/5/31	2018/5/30
Wireless Communication Test set	Agilent	N4010A	MY49081592	2017/7/31	2018/7/30



Software Information					
Test Item	Software Name	Manufacturer	Version		
RSE	EMC32	R&S	V8.40.0		



6 <u>Measurement Uncertainty</u>

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item	Extended Uncertainty	
Transmit Output Power Data	Power [dBm]	U = 0.42 dB
Bandwidth	Magnitude [%]	U = 0.2%
Band Edge Compliance	Disturbance Power [dBm]	U = 1.24 dB
Spurious Emissions, Conducted	Disturbance Power [dBm]	U = 1.62 dB
Field Strength of Spurious Radiation	ERP [dBm]	For 3 m Chamber:
		U = 4.9 dB (30 MHz to 26.5GHz)
Frequency Stability	Frequency Accuracy [ppm]	U = 0.017 ppm

7 Appendixes

Appendix No.	Description
SYBH(Z-RF)20180212006002-2001-A	Appendix_for_GSM
SYBH(Z-RF)20180212006002-2001-B	Appendix_for_WCDMA
SYBH(Z-RF)20180212006002-2001-C	Appendix_for_LTE Band5
SYBH(Z-RF)20180212006002-2001-D	Appendix_for_LTE Band7

Appendix	Description	
Appendix A	Effective (Isotropic) Radiated Power Output Data	
Appendix B	Peak-Average Ratio	
Appendix C	Modulation Characteristics	
Appendix D	Bandwidth	
Appendix E	Band Edges Compliance	
Appendix F	Spurious Emission at Antenna Terminals	
Appendix G	Field Strength of Spurious Radiation	
Appendix H	Frequency Stability	

END